

<b>Notice of References Cited</b>	Application/Control No. 10/814,976		Applicant(s)/Patent Under Reexamination BANJU, KAZUO	
	Examiner John P. Leubecker		Art Unit 3739	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,689,365	11-1997	Takahashi, Susumu	359/362
*	B	US-6,120,433	09-2000	Mizuno et al.	600/102
*	C	US-5,776,049	07-1998	Takahashi, Susumu	600/111
*	D	US-2005/0256371	11-2005	Schara et al.	600/102
*	E	US-2004/0138524	07-2004	Ueda et al.	600/102
*	F	US-6,569,084	05-2003	Mizuno et al.	600/102
*	G	US-6,142,931	11-2000	Kaji, Kunihide	600/114
*	H	US-6,102,850	08-2000	Wang et al.	600/102
*	I	US-6,514,239	02-2003	Shimmura et al.	606/1
*	J	US-5,907,664	05-1999	Wang et al.	700/251
*	K	US-2004/0172012	09-2004	Otsuka et al.	606/001
*	L	US-5,173,802	12-1992	Heller, Rudolf	359/384
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.